

**Search Notes****Application/Control No.**

10/606,134

**Examiner**

Elias Desta

**Applicant(s)/Patent under Reexamination**

FRANCOM ET AL.

**Art Unit**

2857

**SEARCHED**

Class	Subclass	Date	Examiner
702	57,60,65,1 17,189	5/23/2005	E.D
700	67,68	5/23/2005	E.D
324	158.1,715	5/23/2005	E.D
716	5,12	5/23/2005	E.D
703	14,15,16	5/23/2005	E.D

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Method of search: EAST, GOOGLE, YAHOO, CRC, PLUS Searches and IEEE Explore	5/23/2005	E.D
Consulted: Matthew Smith, class 716, au: 2825; Vincent Nguyen, class 324, au: 2858	12/1/2004	E.D
Text or key word searches: see attachment.	5/23/2005	E.D

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
702	57,60,117	5/23/2005	E.D
716	5,12	5/23/2005	E.D
703	14,15,16	5/23/2005	E.D
324/158.1,715; 700/67	5/23/2005	E.D	